

Notice of References Cited	Application/Control No. 10/651,202		Applicant(s)/Patent Under Reexamination MEYER ET AL.	
	Examiner Aileen Chyn		Art Unit 3715	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,561,811 B2	05-2003	Rapoza et al.	434/236
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	M	US-			

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NON-PATENT DOCUMENTS

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